

**Artificial Intelligence Driven Optoelectronic Data Mining for Advanced High-Integration Spectral Sensing**

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Sub forum 2 Latest Research Report on Optoelectronic Materials



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集成电路科学与工程学院 (示范性微电子学院)  
School of Integrated Circuit Science and Engineering (Exemplary School of Microelectronics)

- 1 Miniaturized Spectral Detection Background
- 2 Device Design And Implementation
- 3 Automated High-throughput Testing
- 4 AI Assisted Spectral Reconstruction
- 5 Summary and acknowledgment

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**1 Miniaturized Spectrometer Background**

◆ Applications Development

Chemical Analysis	biomedicine	Doran	Precision Agriculture	Deep Space Exploration	Geological Exploration

Traditional Application

astro observation	material science	Biometric Identification	Precision Medicine	Plastics Separation

Cutting-edge Requirements

Embedded IoT	Portable device	Production line

Miniaturization, Portable, Integration

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**2 S.P. Spectrometer Device**

**◆ Design of semi-suspended 2D MoS<sub>2</sub> devices.**

※ Wang ZL. *Nature* 514, 470–474 (2014).  
 ※ Zhang X. *Nature Nanotech* 10, 151–155 (2015).

In-plane piezoelectric control technology, based on the symmetry breaking of single-layer structures. → Strain -> band structure: bandgap compression and evolution towards indirect bandgap.

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**2 S.P. Spectrometer Device**

**◆ Control the response cutoff wavelength**

※ Liu Y. *Nat Commun*. 11, 1151 (2020)

In-plane gate-induced lattice distortion (Raman characteristic peak shift) → Bandgap Compression → Extended Response Cutoff Wavelength

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**2 S.P. Spectrometer Device**

**◆ Realization of WDM detection**

● WDM Scheme

● Mathematical procedure

● Wave decomposition multiplexing detection diagram

$V_G$  gradual increase → Series of photocurrents  $I(V_G)$  → Differential  $I(V_G)$  → Spectrum curve

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## 2 S.P. Spectrometer Device

**Experimental Results**

● Photocurrent Signal

● Reconstructed Transient Spectrum

The demultiplexing of optical signals in five bands is realized in the wavelength range of 600-800 nm

Lack of Precision

Core How to improve precision in S.P. detection?

The spectrum is encoded in the photoelectric response

Jointly influenced by sampling accuracy and algorithm accuracy

Q1 Characteristic information of photoelectric response has not been fully mined

Q2 Optimize signal sampling and design reconstruction algorithm is important

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## 3 Automated High-throughput Testing

High throughput AI experiment platform

AI design algorithm | HTP photoelectric test | ML feedback

para input

Experimental scheme

HTP preparation | HTP characterization | HTP test

① 八孔货架 ② 相位系统 ③ 八通道移液器 ④ 定角旋涂仪 ⑤ 触片式热台 ⑥ 多功能抓手 ⑦ 机械臂 ⑧ 锁膜仪 ⑨ 多孔货架 ⑩ 光学表征 ⑪ 机械臂 ⑫ 光电子表征

Machine learning

Material gene bank

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## 3 Automated High-throughput Testing

#3 高通量表征  
High-throughput charact

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### 3 Automated High-throughput Testing

**◆ Automatic instrument control**

- File tree
- Test platform

HTP platform's instruments are automatically controlled by the Python, could testing of **device electrical transport (source-meter control)**, **photoelectric response (light source and chopper control)**, and **transient response characteristics (oscilloscope and photon counter)**.

Open source here!

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### 3 Automated High-throughput Testing

**◆ Transient response and analysis**

**Q1 Characteristic information of photoelectric response has not been fully mined**

**Responsivity**

- $V_G \uparrow \lambda_{cutoff} \uparrow$
- $V_G \uparrow \eta_{eq} \downarrow$

Consistent with previous

**Relaxation**

- $V_G \uparrow \text{Relax. Time} \downarrow$
- $\lambda \uparrow \text{Relax. Time} \downarrow$

New Feature!

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### 3 Automated High-throughput Testing

**◆ Carrier kinetic image for relaxation feature**

$$\frac{dn_{\text{trap}}}{dt} = k_{\text{de-trap}} n_{\text{trap}} - k_{\text{trap}} n_{\text{free}} \left(1 - \frac{n_{\text{trap}}}{N_{\text{trap}}}\right) \quad \frac{dn_{\text{trap}}}{dt} = -k_{\text{non-rad.}} n_{\text{trap}} - k_{\text{de-trap}} n_{\text{trap}} + k_{\text{trap}} n_{\text{free}} \left(1 - \frac{n_{\text{trap}}}{N_{\text{trap}}}\right)$$

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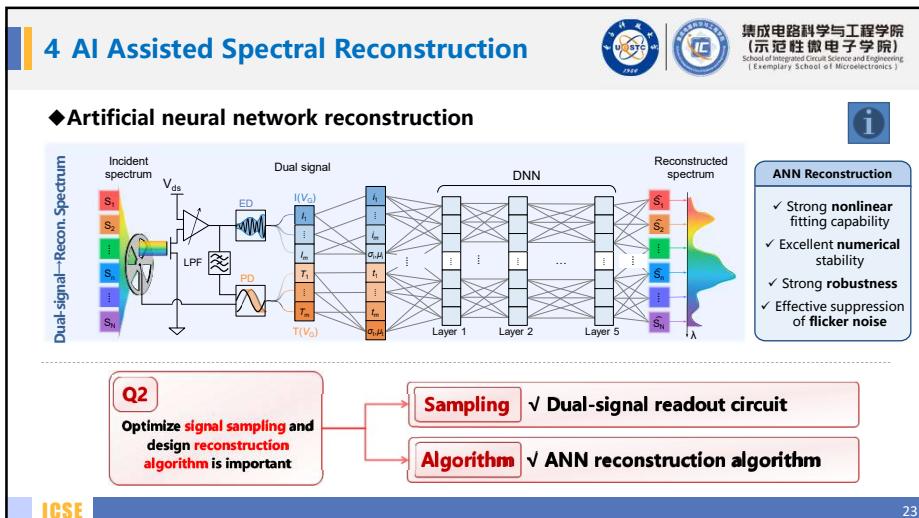
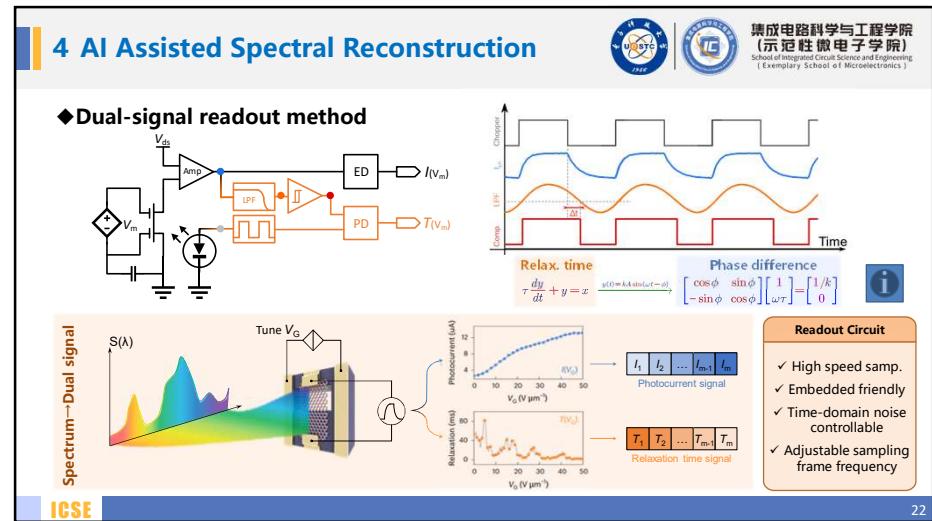
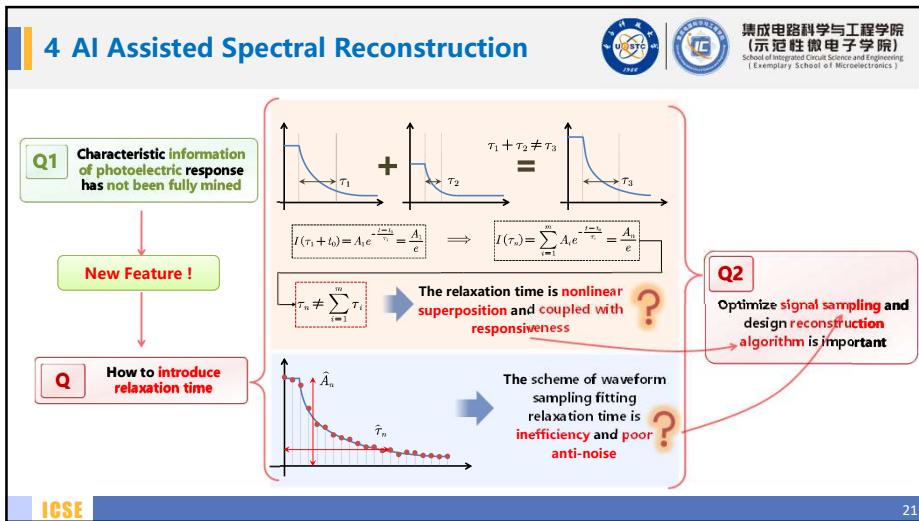
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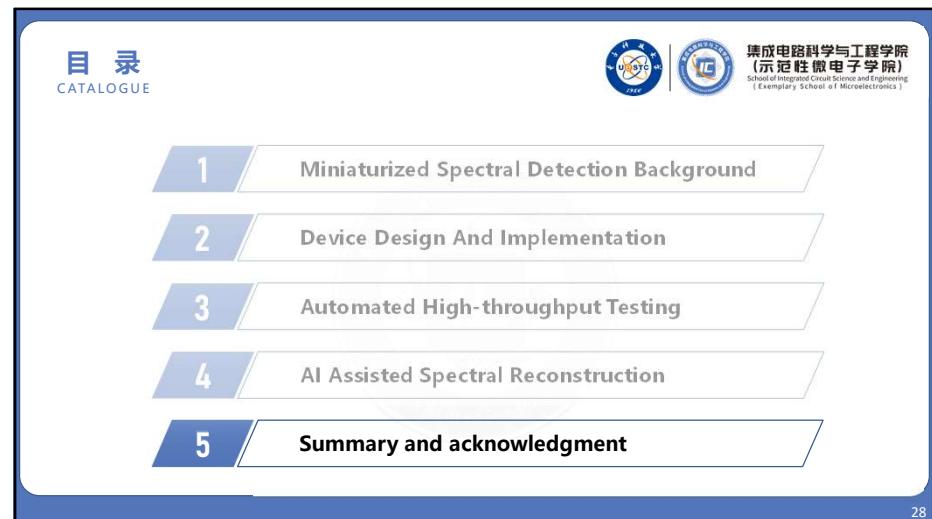
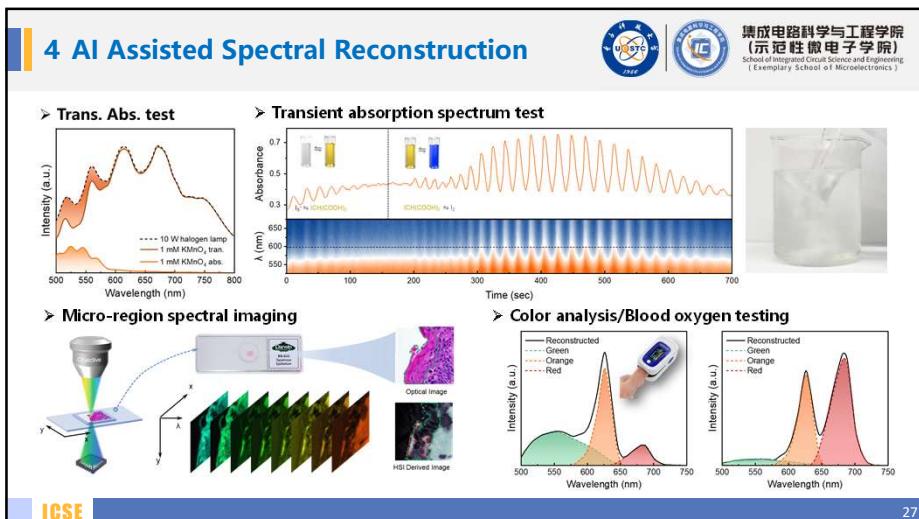
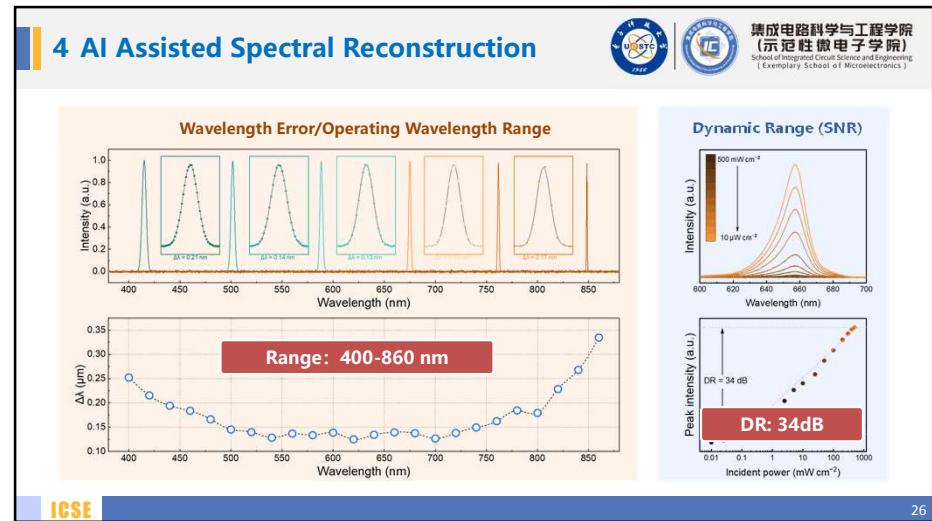
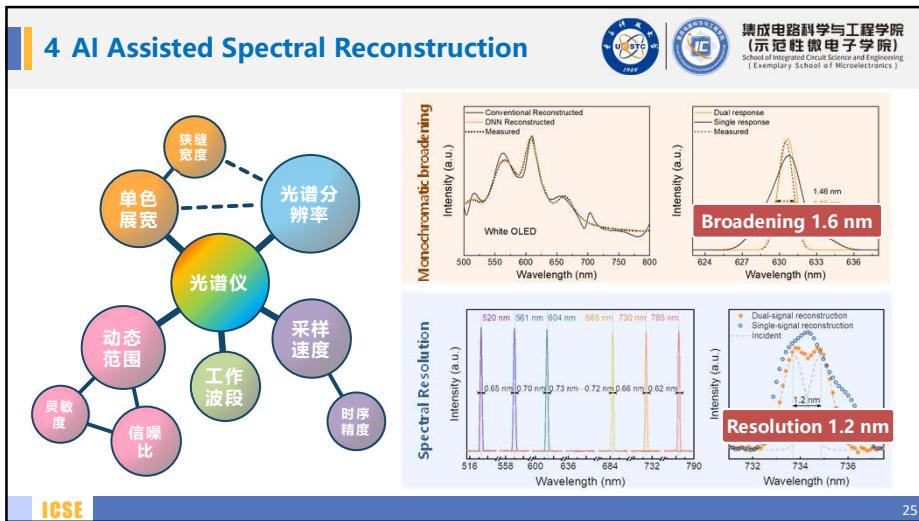
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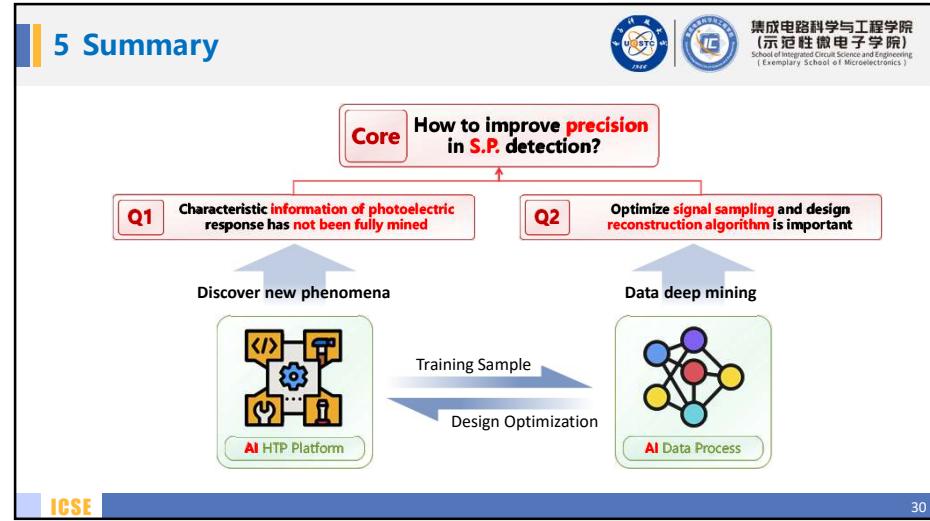
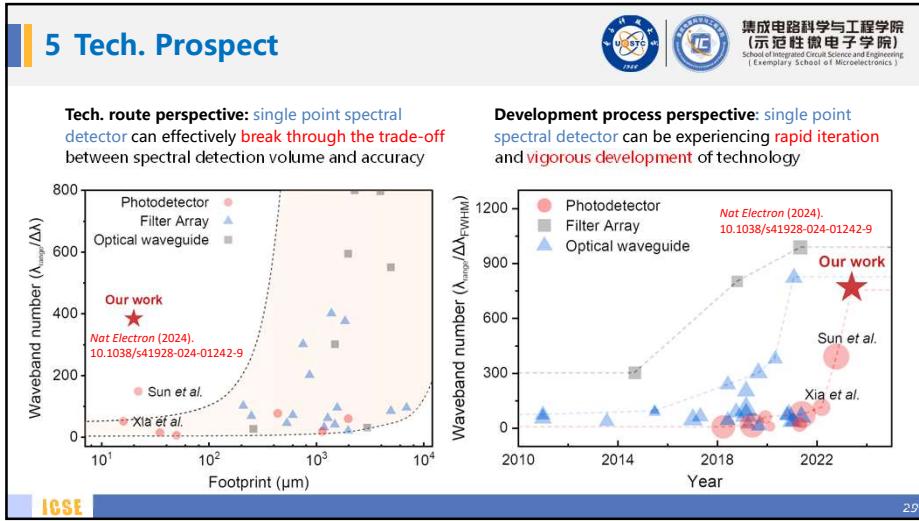
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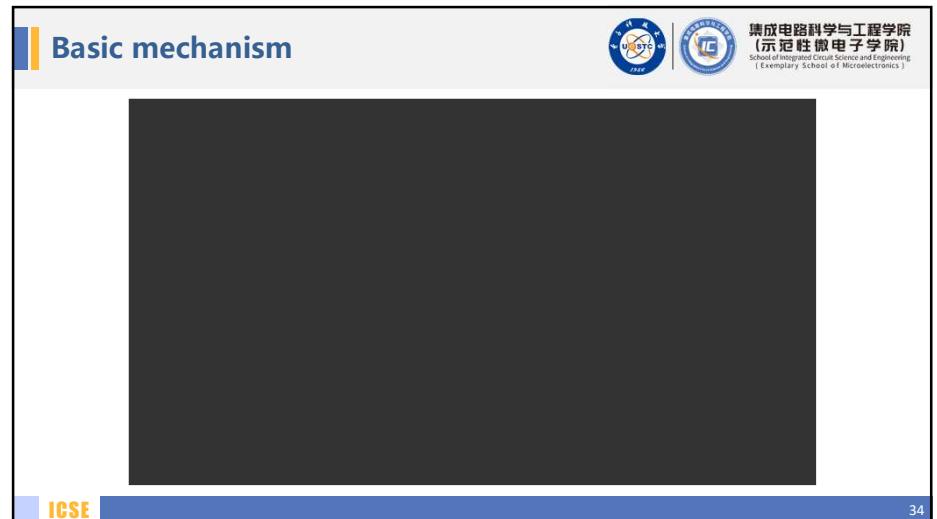
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## Relaxation Time Sampling

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Relaxation Time Sampling

Chopping Schematic

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## Neural Network Reconstruction

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Neural Network Reconstruction

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